Electronic Supplementary Material (ESI) for Physical Chemistry Chemical Physics.

Electronic Supplementary Information

DMPC vesicle structure and dynamics in the presence of low amounts of the saponin aescin

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Pair distance distribution functions from SAXS

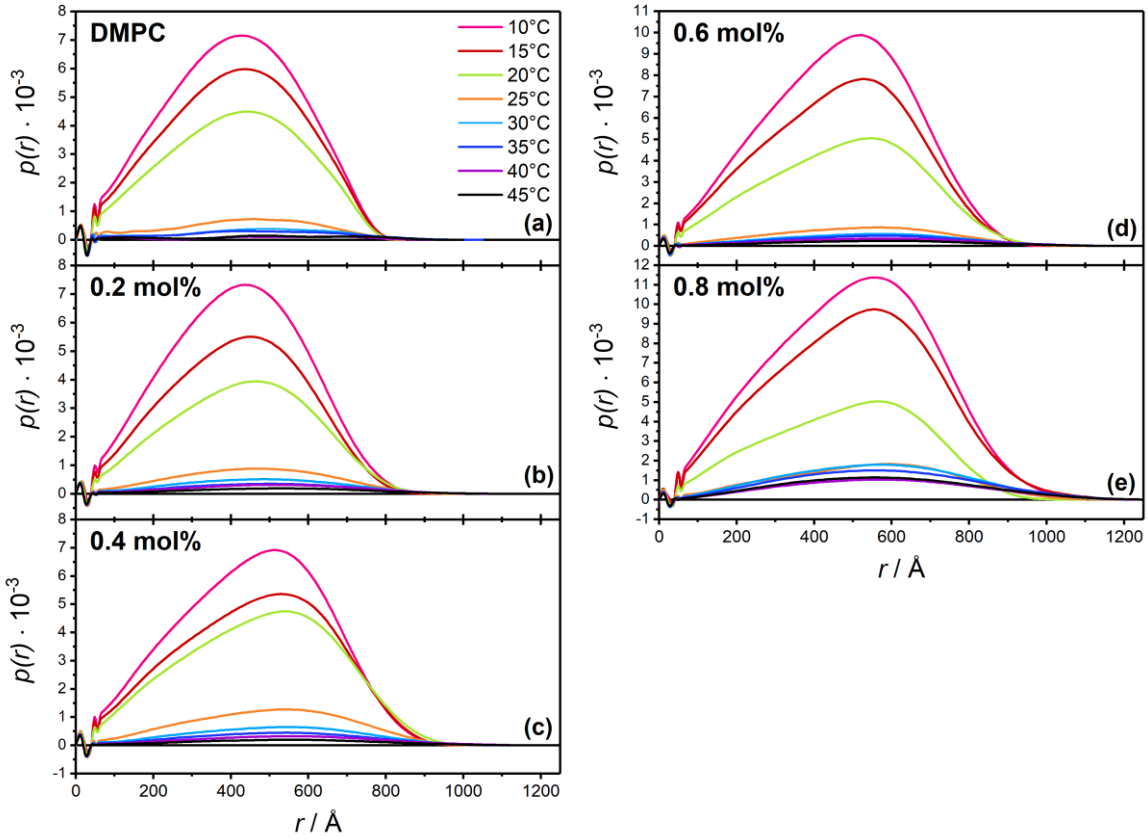

Figure S1 : Pair distance distribution functions (*p(r)*) of vesicle suspensions of (a) DMPC and (b)-(e) DMPC containing low amounts of aescin in the temperature range between 10 °C and 45 °C in steps of 5 °C. They were obtained from a standard IFT analysis using GIFT.[1]

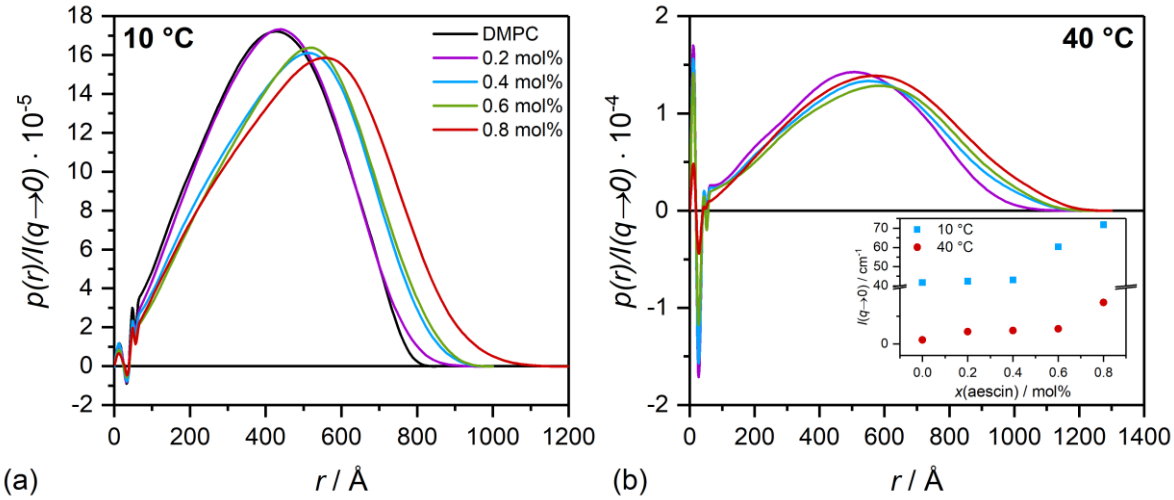

Figure S2: Pair distance distribution functions ($p(r)$) of vesicle suspensions of DMPC and DMPC containing low amounts of aescin at 10 °C and 40 °C. These functions were normalized by the intensity at $q \rightarrow 0$. The evolution of the $I(q \rightarrow 0)$ with aescin content is shown in the inset of panel (b).

Thickness pair distance distribution functions from SAXS

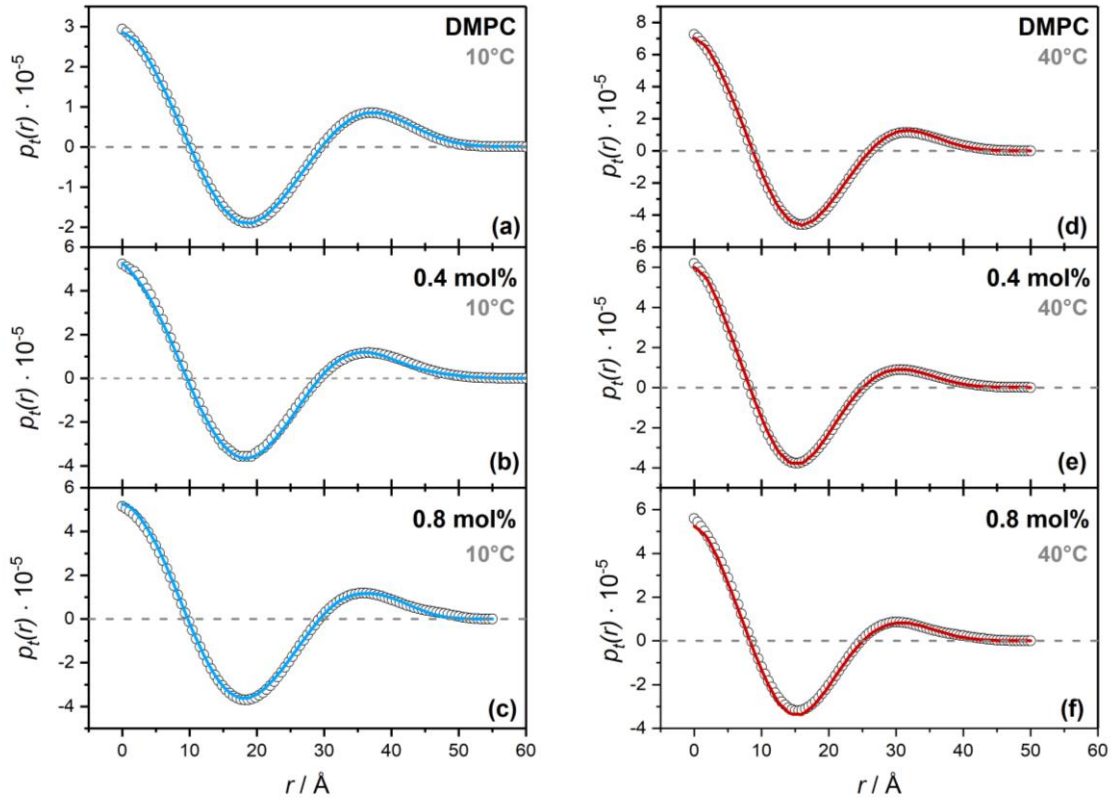

Figure S3: Thickness pair distance distribution functions ($p_t(r)$) (circles) for vesicle suspensions of DMPC and DMPC containing low amounts of aescin at (a)-(c) 10 °C and (d)-(f) 40 °C. $p_t(r)$ functions were obtained using GIFT.[1] Solid lines represent the calculated $p_t(r)$ functions by DECON for deconvolution and calculation of the ED profiles ($\Delta\rho$) in Fig. 9 in the manuscript.[2]

References

(1) Bergmann, A.; Fritz, G.; Glatter, O. *Journal of Applied Crystallography* 2000, 33,1212-1216.
(2) Mittelbach, R.; Glatter, O. *Journal of Applied Crystallography* 1998, 31, 600-608.